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- Max $r_{DS(on)}$ = 6.0 m Ω at V_{GS} = 4.5 V, I_D = 21 A
- 100% UIL test
- RoHS Compliant

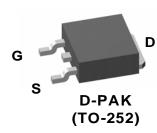


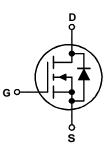
General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $r_{DS(on)}$ and fast switching speed.

Applications

- Vcore DC-DC for Desktop Computers and Servers
- VRM for Intermediate Bus Architecture





MOSFET Maximum Ratings T_C = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V _{DS}	Drain to Source Voltage			25	V	
V _{GS}	Gate to Source Voltage			±20	V	
	Drain Current -Continuous (Package limited)	T _C = 25 °C		50	A	
	-Continuous (Silicon limited)	T _C = 25 °C		131		
I _D	-Continuous	T _A = 25 °C	(Note 1a)	27		
	-Pulsed			200		
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	72	mJ	
	Power Dissipation	T _C = 25 °C		65	14/	
P _D	Power Dissipation	T _A = 25 °C	(Note 1a)	3.7	W	
T _J , T _{STG}	Operating and Storage Junction Temperature R	ange		-55 to +175	°C	

Thermal Characteristics

R_{\thetaJC}	Thermal Resistance, Junction to Case		2.3	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	40	C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD6760A	FDD6760A	D-PAK (TO-252)	13 "	16 mm	2500 units

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March 2015

	FDD6760A N-Channel Power Trench [®] MOSFET
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Units

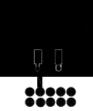
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	25			V
ΔBV _{DSS} ΔT,	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		16		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 20 V, V _{GS} = 0 V			1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
	acteristics					
V _{GS(th)}	Gate to Source Threshold Voltage	V _{GS} = V _{DS} , I _D = 250 μA	1.0	1.6	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		-7		mV/°C
		V _{GS} = 10 V, I _D = 27 A		2.3	3.2	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 21 \text{ A}$		4.4	6.0	mΩ
		V _{GS} = 10 V, I _D = 27 A, T _J = 150 °C		3.5	4.9	
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 27 A		186		S
Dvnamio	c Characteristics					
C _{iss}	Input Capacitance			2380	3170	pF
C _{oss}	Output Capacitance	$V_{DS} = 13 V, V_{GS} = 0 V,$		525	700	pF
C _{rss}	Reverse Transfer Capacitance	f = 1MHz		470	710	pF
R _q	Gate Resistance	f = 1MHz		1.3		Ω
*						
	ng Characteristics			10	20	ns
t _{d(on)}	Turn-On Delay Time	Vpp = 13 V. lp = 27 A.		10 9	20 18	ns
t _{d(on)} t _r	Turn-On Delay Time Rise Time	$V_{DD} = 13$ V, I _D = 27 A, V _{GS} = 10 V, R _{GEN} = 6 Ω		-	-	-
t _{d(on)} t _r t _{d(off)}	Turn-On Delay Time			9	-	ns
t _{d(on)} t _r t _{d(off)} t _f	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	V_{GS} = 10 V, R_{GEN} = 6 Ω		9 28	-	ns ns
t _{d(on)} t _r t _{d(off)} t _f Q _g	Turn-On Delay Time Rise Time Turn-Off Delay Time	V_{GS} = 10 V, R_{GEN} = 6 Ω		9 28 6	18	ns ns ns
t _{d(on)} t _r t _{d(off)} t _f Q _g Q _g	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge			9 28 6 44	18 62	ns ns ns nC
t _{d(on)} t _r t _{d(off)} t _f Q _g Q _g Q _{gs}	Turn-On Delay TimeRise TimeTurn-Off Delay TimeFall TimeTotal Gate ChargeTotal Gate Charge	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 5 \text{ V}$ $V_{DD} = 13 \text{ V},$		9 28 6 44 25	18 62	ns ns nS nC nC
t _{d(on)} t _r t _{d(off)} t _f Q _g Q _{gs} Q _{gs} Q _{gd}	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 5 \text{ V}$ $V_{DD} = 13 \text{ V},$		9 28 6 44 25 6	18 62	ns ns nC nC nC
t _{d(on)} t _r t _{d(off)} t _f Q _g Q _{gs} Q _{gd} Drain-Sc	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge Durce Diode Characteristics	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 5 \text{ V}$ $V_{DD} = 13 \text{ V},$ $I_{D} = 17 \text{ A}$		9 28 6 44 25 6	18 62	ns ns nC nC nC nC
t _{d(on)} t _r t _{d(off)} t _f Q _g Q _{gs} Q _{gd} Drain-Sc	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 5 \text{ V}$ $V_{DD} = 13 \text{ V},$ $I_D = 17 \text{ A}$ $V_{GS} = 0 \text{ V}, \text{ I}_S = 3.1 \text{ A}$ (Note 2)		9 28 6 44 25 6 9.9	18 62 35	ns ns nC nC nC
t _{d(on)} t _r t _{d(off)} t _f Q _g Q _{gs} Q _{gd} Drain-Sc V _{SD}	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge Durce Diode Characteristics	$\begin{array}{c} V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \ \Omega \\ \\ \hline \\ V_{GS} = 0 \text{ V to } 10 \text{ V} \\ \hline \\ V_{GS} = 0 \text{ V to } 5 \text{ V} \\ \hline \\ I_D = 17 \text{ A} \\ \end{array}$		9 28 6 44 25 6 9.9	18 62 35 1.2	ns ns nC nC nC nC
t _{d(on)} t _r t _{d(off)} t _f Q _g Q _{gs} Q _{gg}	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge Total Gate Charge Gate to Source Charge Gate to Drain "Miller" Charge Durce Diode Characteristics Source to Drain Diode Forward Voltage	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 5 \text{ V}$ $V_{DD} = 13 \text{ V},$ $I_D = 17 \text{ A}$ $V_{GS} = 0 \text{ V}, \text{ I}_S = 3.1 \text{ A}$ (Note 2)		9 28 6 44 25 6 9.9 0.7 0.8	18 62 35 1.2 1.3	ns ns nC nC nC nC

Test Conditions

Min

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Max



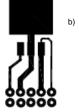
Electrical Characteristics $T_J = 25$ °C unless otherwise noted

Parameter

Symbol

a) 40 °C/W when mounted on a 1 in² pad of 2 oz copper

2





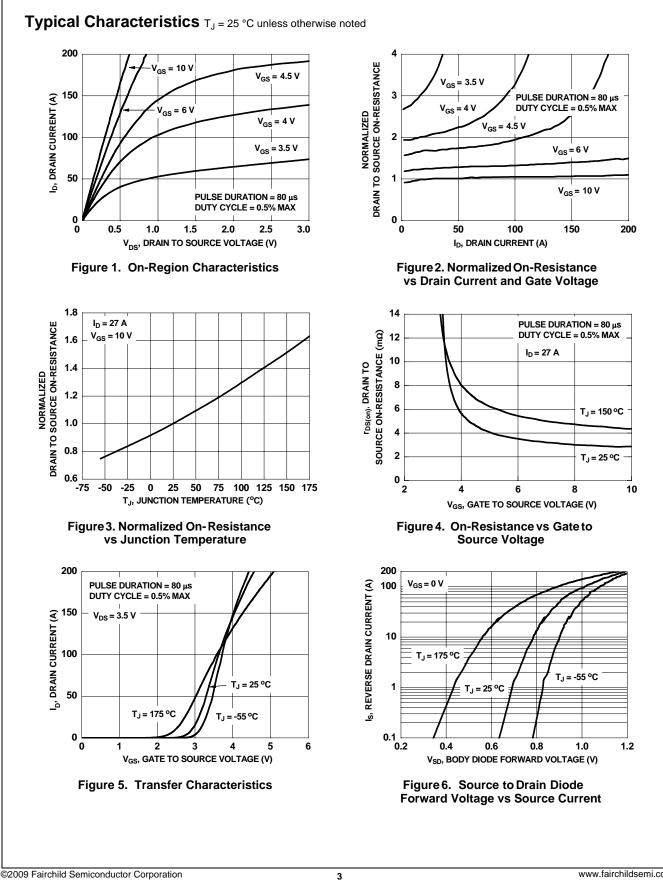
b) 96 °C/W when mounted on a minimum pad.

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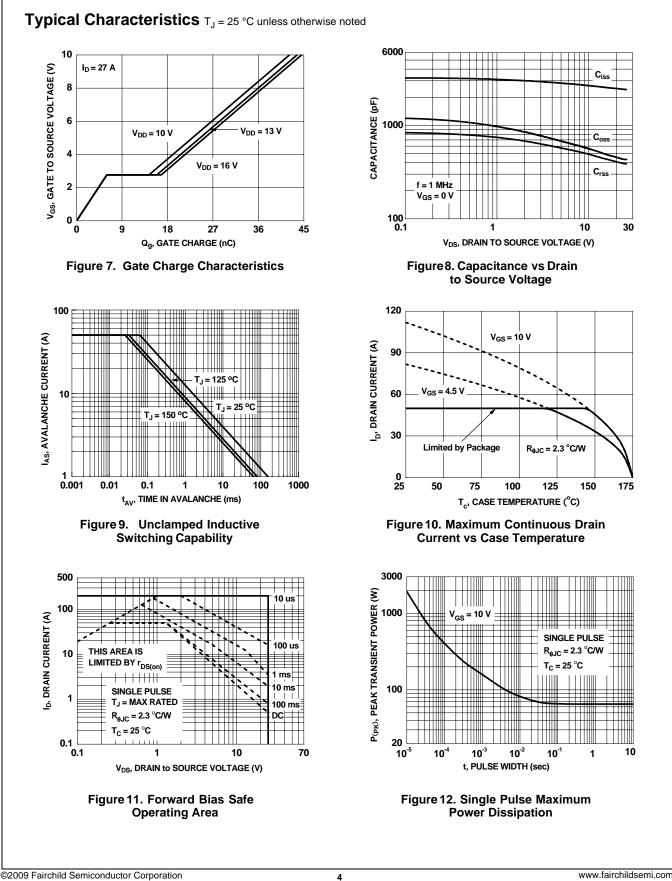
2: Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%. **3:** E_{AS} of 72 mJ is based on starting T_J = 25 °C, L = 1 mH, I_{AS} = 12 A, V_{DD} = 23 V, V_{GS} = 10 V. 100% test at L = 0.1 mH, I_{AS} = 29 A. ©2009 Fairchild Semiconductor Corporation FDD6760A Rev. 1.2

FDD6760A N-Channel Power Trench[®] MOSFET



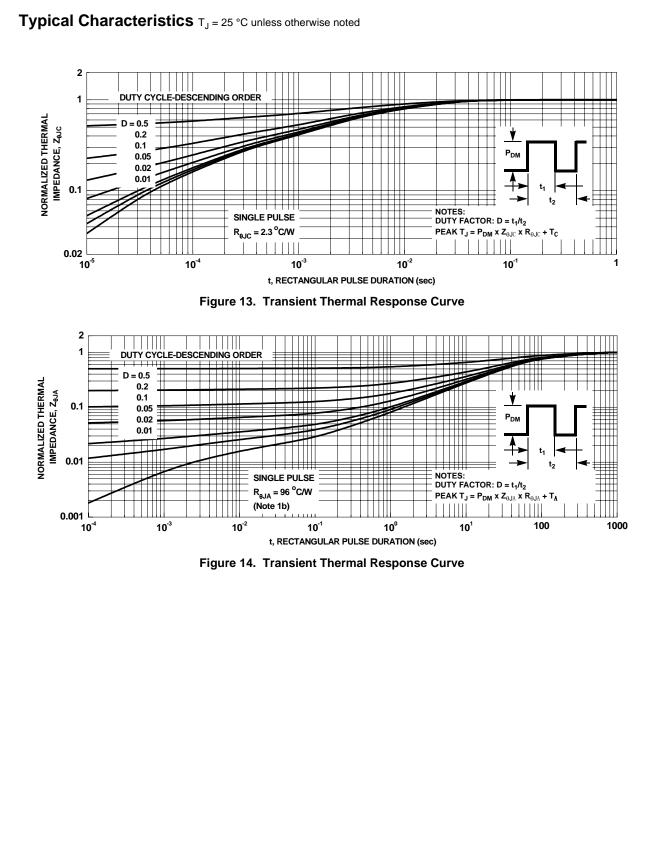
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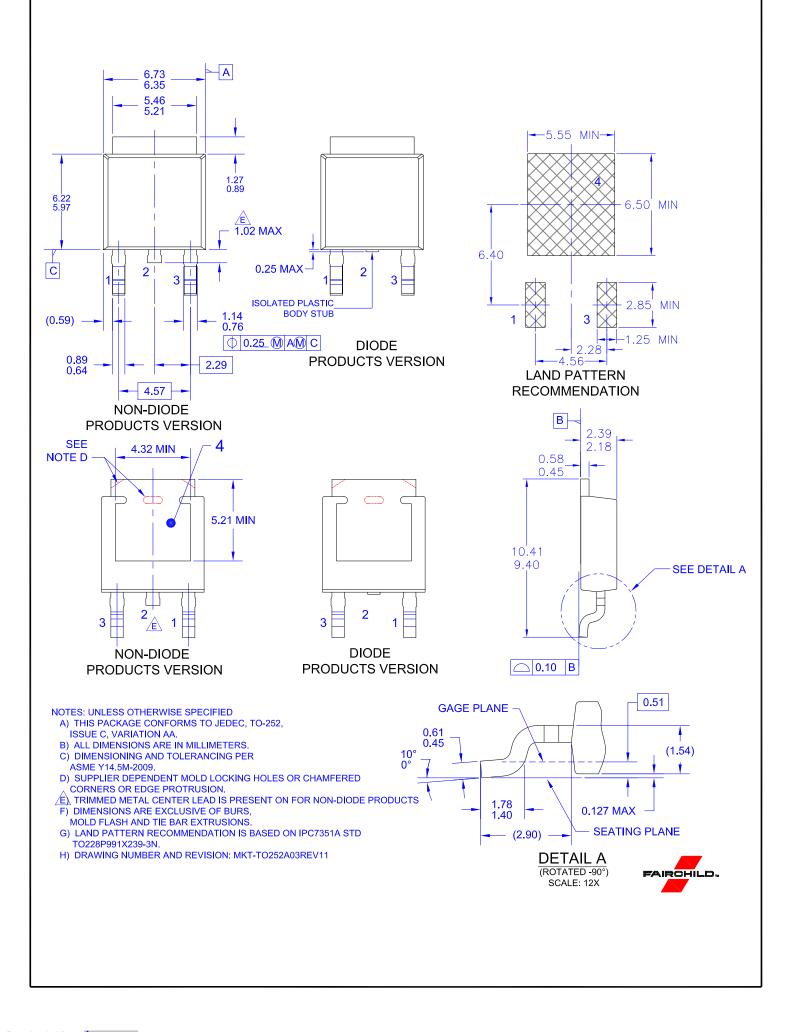
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